UNISONIC TECHNOLOGIES CO., LTD

10N70-C **Power MOSFET**

10A, 700V N-CHANNEL **POWER MOSFET**

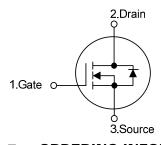
DESCRIPTION

The UTC 10N70-C is a high voltage and high current power MOSFET, designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

FEATURES

- * $R_{DS(ON)}$ < 0.86 Ω @ V_{GS} = 10 V
- * Fast switching
- * 100% avalanche tested
- * Improved dv/dt capability

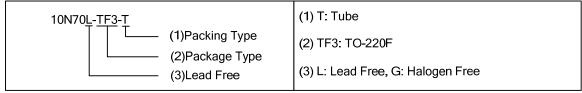
SYMBOL



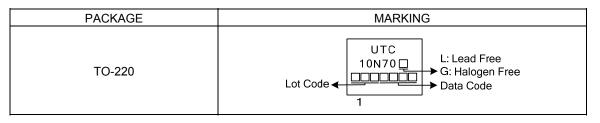
ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
10N70L-TF3-T	10N70G-TF3-T	TO-220F	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



MARKING INFORMATION



TO-220F

www.unisonic.com.tw 1 of 6 10N70-C Power MOSFET

■ **ABSOLUTE MAXIMUM RATINGS** (T_C = 25°C unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	700	V	
Gate-Source Voltage		V_{GSS}	±30	V	
Avalanche Current (Note 2)		I _{AR}	10	Α	
Drain Current	Continuous	I _D	10	Α	
	Pulsed (Note 2)	I _{DM}	40	Α	
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	150	mJ	
	Repetitive (Note 2)	E _{AR}	15.6	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns	
Power Dissipation		P_{D}	50	W	
Junction Temperature		TJ	+150	°C	
Operating Temperature		T _{OPR}	-55 ~ +150	°C	
Storage Temperature		T _{STG}	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L = 3mH, I_{AS} = 10A, V_{DD} = 50V, R_G = 25 Ω Starting T_J = 25°C
- 4. $I_{SD} \le 9.5A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	θ_{JA}	62.5	°C/W	
Junction to Case	θ _{JC}	2.5	°C/W	

10N70-C

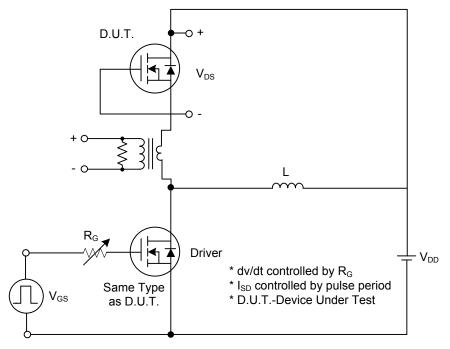
■ ELECTRICAL CHARACTERISTICS(T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV_{DSS}	$V_{GS} = 0V, I_D = 250\mu A$	700			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} = 700V, V _{GS} = 0V			10	μA
Cata Caurae Lagkage Current	Forward	-	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
Gate-Source Leakage Current	Reverse	I _{GSS}	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
Breakdown Voltage Temperature Coefficient		$\Delta BV_{DSS}/\Delta T_J$	I_D = 250 μ A, Referenced to 25°C		0.7		V/°C
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	$V_{GS} = 10V, I_D = 5A$		0.75	0.86	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance	nput Capacitance				1495	1700	pF
Output Capacitance		Coss	V _{DS} =25V, V _{GS} =0V, f=1.0 MHz		414	200	pF
Reverse Transfer Capacitance		C_{RSS}			8	20	pF
SWITCHING CHARACTERISTICS	;						
Turn-On Delay Time		t _{D(ON)}			99	120	ns
Turn-On Rise Time		t_R	V_{DD} =30V, I_{D} =0.5A, R_{G} =25 Ω		132	160	ns
Turn-Off Delay Time		$t_{D(OFF)}$	(Note 1, 2)		233	270	ns
Turn-Off Fall Time		t_{F}			121	140	ns
Total Gate Charge		Q_G	\\ _50\\ _4.2\\ \\ _10.\\		43	60	nC
Gate-Source Charge		Q_GS	V _{DS} =50V, I _D =1.3A, V _{GS} =10 V (Note 1, 2)		13		nC
Gate-Drain Charge		Q_GD	(Note 1, 2)		10		nC
DRAIN-SOURCE DIODE CHARAC	CTERISTIC	S AND MAX	IMUM RATINGS				
Drain-Source Diode Forward Voltage		V_{SD}	$V_{GS} = 0 \text{ V}, I_{S} = 10 \text{A}$			1.4	V
Maximum Continuous Drain-Source Diode		Is				10	A
Forward Current						10	A
Maximum Pulsed Drain-Source Diode		I _{SM}				40	Α
Forward Current						40	^
Reverse Recovery Time		t _{rr}	$V_{GS} = 0 \text{ V}, I_{S} = 10\text{A},$		420		ns
Reverse Recovery Charge		Q_{RR}	dI _F / dt = 100 A/µs (Note 1)		4.2		μC

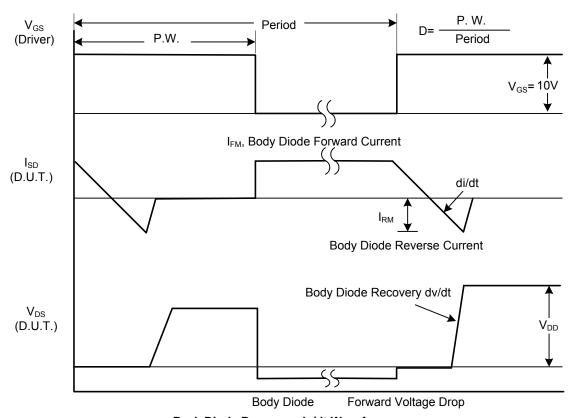
Notes: 1. Pulse Test : Pulse width \leq 300 μ s, Duty cycle \leq 2%

^{2.} Essentially independent of operating temperature

■ TEST CIRCUITS AND WAVEFORMS

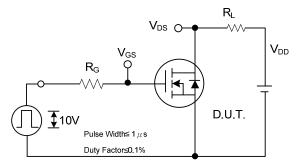


Peak Diode Recovery dv/dt Test Circuit

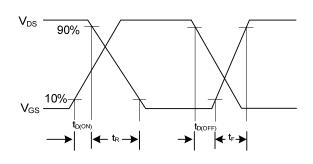


Peak Diode Recovery dv/dt Waveforms

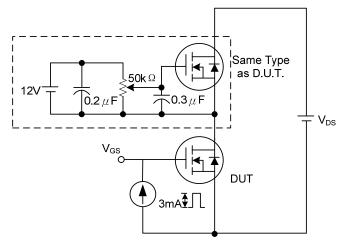
■ TEST CIRCUITS AND WAVEFORMS (Cont.)



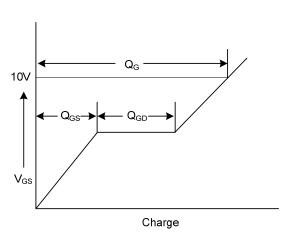
Switching Test Circuit



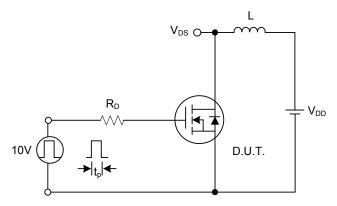
Switching Waveforms



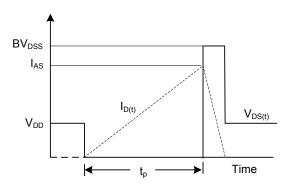
Gate Charge Test Circuit



Gate Charge Waveform

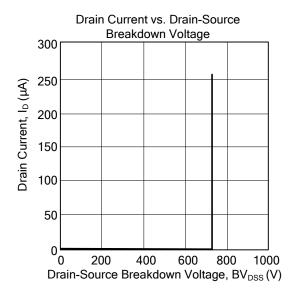


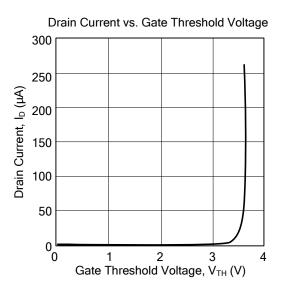
Unclamped Inductive Switching Test Circuit

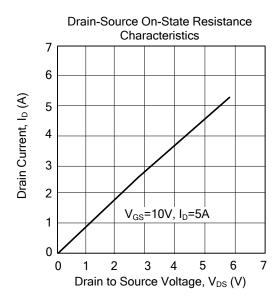


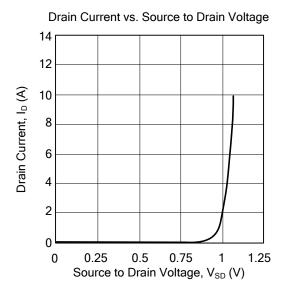
Unclamped Inductive Switching Waveforms

■ TYPICAL CHARACTERISTICS









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